

Is Now Part of



ON Semiconductor®

To learn more about ON Semiconductor, please visit our website at <u>www.onsemi.com</u>

Please note: As part of the Fairchild Semiconductor integration, some of the Fairchild orderable part numbers will need to change in order to meet ON Semiconductor's system requirements. Since the ON Semiconductor product management systems do not have the ability to manage part nomenclature that utilizes an underscore (_), the underscore (_) in the Fairchild part numbers will be changed to a dash (-). This document may contain device numbers with an underscore (_). Please check the ON Semiconductor website to verify the updated device numbers. The most current and up-to-date ordering information can be found at www.onsemi.com. Please email any questions regarding the system integration to Fairchild_questions@onsemi.com.

ON Semiconductor and the ON Semiconductor logo are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of ON Semiconductor's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using ON Semiconductor data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. ON Semiconductor does not convey any license under its patent rights of others. ON Semiconductor products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or unavteries, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out or i, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that ON Semiconductor was negligent regarding the design or manufacture of the part. ON Semiconductor and is officers, employees, weni four in any manner.



December 2013



FCP4N60 — N-Channel SuperFET[®] MOSFET

FCP4N60 N-Channel SuperFET[®] MOSFET **600 V, 3.9 A, 1.2** Ω

Features

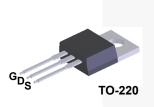
- 650 V @ T_J = 150°C
- Typ. R_{DS(on)} = 1.0 Ω
- Ultra Low Gate Charge (Typ. Q_g = 12.8 nC)
- Low Effective Output Capacitance (Typ. C_{oss(eff.)} = 32 pF)
- 100% Avalanche Tested
- · RoHS Compliant

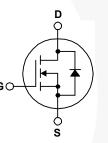
Application

- LCD / LED / PDP TV and Monitor Lighting
- Solar Inverter
- AC-DC Power Supply

Description

SuperFET® MOSFET is Fairchild Semiconductor's first generation of high voltage super-junction (SJ) MOSFET family that is utilizing charge balance technology for outstanding low onresistance and lower gate charge performance. This technology is tailored to minimize conduction loss, provide superior switching performance, dv/dt rate and higher avalanche energy. Consequently, SuperFET MOSFET is very suitable for the switching power applications such as PFC, server/telecom power, FPD TV power, ATX power and industrial power applications.





MOSFET Maximum Ratings T_C = 25°C unless otherwise noted.

Symbol	Parameter	FCP4N60	Unit	
V _{DSS}	Drain-Source Voltage	600	V	
I _D	Drain Current - Continuous ($T_C = 25^{\circ}C$) - Continuous ($T_C = 100^{\circ}C$)		3.9 2.5	A A
I _{DM}	Drain Current - Pulsed	(Note 1)	11.7	A
V _{GSS}	Gate-Source voltage		± 30	V
E _{AS}	Single Pulsed Avalanche Energy	(Note 2)	128	mJ
I _{AR}	Avalanche Current	(Note 1)	3.9	A
E _{AR}	Repetitive Avalanche Energy	(Note 1)	5.0	mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	4.5	V/ns
P _D	Power Dissipation $(T_C = 25^{\circ}C)$ - Derate Above $25^{\circ}C$		50 0.4	W W/°C
T _{J,} T _{STG}	Operating and Storage Temperature Range		-55 to +150	°C
Τ _L	Maximum Lead Temperature for Soldering, 1/8" from Case for 5 Seconds.		300	°C

Thermal Characteristics

Symbol	Parameter	FCP4N60	Unit	
$R_{\theta JC}$	Thermal Resistance, Junction to Case, Max.	2.5	°C/W	
	Thermal Resistance, Junction to Ambient, Max.	83	C/W	
R _{θJA}			1	

FCP4N60
N-Channel
SuperFET®
MOSFET

		Top Mark	Package	ckage Packing Method Reel Size		Та	ape Width	Qu	Quantity 50 units	
		FCP4N60	TO-220	Tube	N/A		N/A			
Electric	al Char	racteristics T _C = 25	5ºC unless oth	nerwise noted.						
Symbol		Parameter		Conditions		Min.	Тур.	Max.	Unit	
Off Chara	cteristics									
BV _{DSS}	Drain-Source Breakdown Voltage		$V_{GS} =$	$V_{GS} = 0 \text{ V}, \text{ I}_{D} = 250 \mu\text{A}, \text{ T}_{J} = 25^{\circ}\text{C}$		600			V	
			$V_{GS} =$	$V_{GS} = 0 \text{ V}, \text{ I}_{D} = 250 \mu\text{A}, \text{ T}_{J} = 150^{\circ}\text{C}$			650		V	
ΔBV_{DSS} / ΔT_{J}	Breakdow Coefficien	vn Voltage Temperature t	I _D = 25	$I_D = 250 \ \mu\text{A}$, Referenced to 25°C			0.6		V/°C	
BV _{DS}	Drain-Sou Voltage	urce Avalanche Breakdow	/n V _{GS} =	V _{GS} = 0 V, I _D = 3.9 A			700		V	
I _{DSS}	Zero Gate	e Voltage Drain Current		$V_{DS} = 600 \text{ V}, V_{GS} = 0 \text{ V}$ $V_{DS} = 480 \text{ V}, T_{C} = 125^{\circ}\text{C}$				1 10	μΑ μΑ	
I _{GSSF}	Gate-Bod	y Leakage Current, Forw	ard V _{GS} =	$V_{GS} = 30 \text{ V}, \text{ V}_{DS} = 0 \text{ V}$				100	nA	
I _{GSSR}	Gate-Bod	y Leakage Current, Reve	rse V _{GS} =	-30 V, V _{DS} = 0 V				-100	nA	
On Charao	cteristics									
V _{GS(th)}	Gate Thre	eshold Voltage	$V_{DS} =$	V _{GS} , I _D = 250 μA		3.0		5.0	V	
R _{DS(on)}	Static Dra On-Resist	in-Source tance	V _{GS} =	V_{GS} = 10 V, I _D = 2.0 A			1.0	1.2	Ω	
9 _{FS}	Forward 1	Fransconductance	$V_{DS} =$	40 V, I _D = 2.0 A			3.2		S	
Dynamic (Characteris	tics								
C _{iss}	Input Cap	acitance		$V_{DS} = 25 V, V_{GS} = 0 V,$			415	540	pF	
C _{oss}	Output Ca	apacitance	f = 1.0	MHz			210	275	pF	
C _{rss}	Reverse 7	Fransfer Capacitance					19.5		pF	
C _{oss}	Output Ca	apacitance	$V_{DS} =$	480 V, $V_{GS} = 0$ V, f =	1.0 MHz		12	16	pF	
C _{oss} eff.	Effective	Output Capacitance	$V_{DS} =$	$V_{DS} = 0 V$ to 400 V, $V_{GS} = 0 V$			32		pF	
Switching	Characteri	stics								
t _{d(on)}	Turn-On [Delay Time		$V_{DD} = 300 \text{ V}, \text{ I}_D = 3.9 \text{ A}$ $R_G = 25 \Omega$		-	16	45	ns	
t _r	Turn-On F	Rise Time	$R_{G} = 2$				45	100	ns	
t _{d(off)}	Turn-Off	Delay Time					36	85	ns	
t _f	Turn-Off F	Fall Time			(Note 4)		30	70	ns	
Qg	Total Gate	e Charge		$V_{DS} = 480 \text{ V}, \text{ I}_{D} = 3.9 \text{ A}$			12.8	16.6	nC	
Q _{gs}	Gate-Sou	rce Charge	V _{GS} =	10 V			2.4		nC	
Q _{gd}	Gate-Drai	n Charge			(Note 4)		7.1		nC	
Drain-Sou	rce Diode (Characteristics and Max	imum Rating	s				/ F		
I _S	Maximum Continuous Drain-Source Diode Forward Current					3.9	Α			
I _{SM}	Maximum	Pulsed Drain-Source Dic	ode Forward C	Current				11.7	Α	
V_{SD}	Drain-Sou	urce Diode Forward Voltag		0 V, I _S = 3.9 A				1.4	V	
t _{rr}	Reverse F	Recovery Time		$V_{GS} = 0 V, I_{S} = 3.9 A$			277		ns	
Q _{rr}	Reverse F	Recovery Charge	dl _F /dt =	=100 A/μs			2.07		μC	

Notes:

1. Repetitive rating: pulse-width limited by maximum junction temperature.

2. I_{AS} = 1.9 A, V_{DD} = 50 V, R_G = 25 Ω , starting T_J = 25°C.

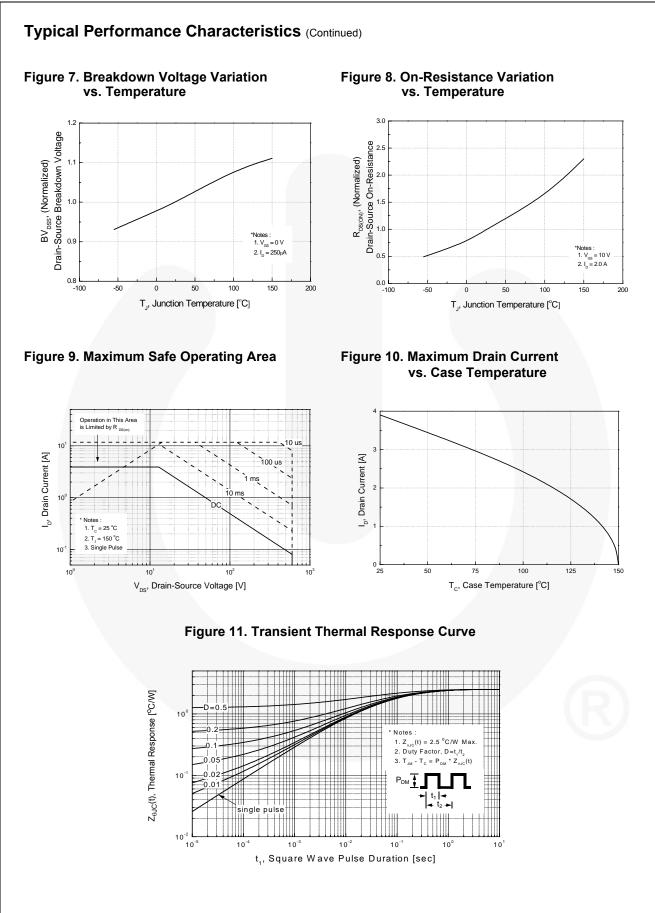
3. I_{SD} \leq 3.9 A, di/dt \leq 200 A/µs, V_{DD} \leq BV_{DSS}, starting T_J = 25°C.

4. Essentially independent of operating temperature typical characteristics.

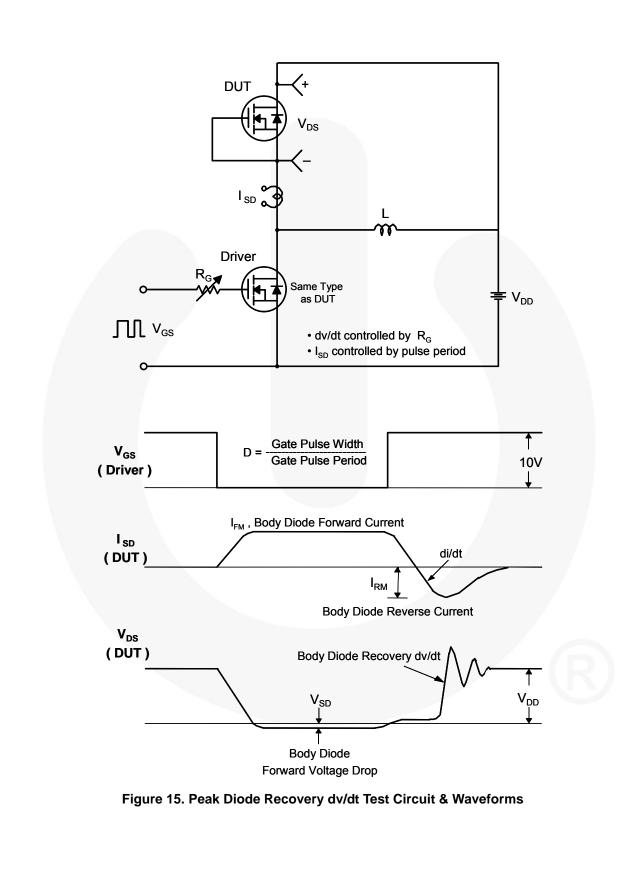
Typical Performance Characteristics Figure 1. On-Region Characteristics Figure 2. Transfer Characteristics V_{GS} 15.0 V 10.0 V 8.0V 7.5 V 7.0 V 6.5 V 6.0 V 10 10¹ Тор ₹ I_D, Drain Current [A] I_b, Drain Current 150°C 5.5 V Bottom 10⁰ 25°C -55°C Notes : 1. 250µs Pulse Test * Note 1. V_{DS} = 40V 2. 250µs Pulse Test 2. T_c = 25^oC 0.1 10⁻¹ 0.1 10 2 4 6 8 10 V_{DS}, Drain-Source Voltage [V] $\rm V_{_{GS}}$, Gate-Source Voltage $\,[V]$ Figure 3. On-Resistance Variation vs. Figure 4. Body Diode Forward Voltage **Drain Current and Gate Voltage** Variation vs. Source Current and Temperatue [0], Drain-Source On-Resistance 10 ₹ **Reverse Drain Current** $V_{GS} = 10V$ 10 150°C = 201/ 25°C BR, R_{DS(ON)} I Notes : 1. V_{GS} = 0V * Note : T = 25°C 2. 250µs Pulse Test 0.0 10 2.5 5.0 7.5 10.0 12.5 0.2 0.4 0.6 0.8 1.0 1.2 I_D, Drain Current [A] V_{SD}, Source-Drain Voltage [V] **Figure 5. Capacitance Characteristics Figure 6. Gate Charge Characteristics** 1200 12 $$\begin{split} \mathbf{C}_{_{\mathrm{iss}}} &= \mathbf{C}_{_{\mathrm{gs}}} + \mathbf{C}_{_{\mathrm{gd}}} \left(\mathbf{C}_{_{\mathrm{ds}}} = \text{shorted} \right) \\ \mathbf{C}_{_{\mathrm{oss}}} &= \mathbf{C}_{_{\mathrm{ds}}} + \mathbf{C}_{_{\mathrm{gd}}} \end{split}$$ V_{DS} = 120V V_{DS} = 300V 1000 10 V_{GS}, Gate-Source Voltage [V] V_{DS} = 480V 800 ۶ Capacitance [pF] Notes : 1. V_{gs} = 0 V 2. f = 1 MHz 600 400 200 2 * Note : I_D = 3.9A 0 L 10⁶ 0 k 0 . . . 10 10 15 V_{DS}, Drain-Source Voltage [V] Q_G, Total Gate Charge [nC]

©2008 Fairchild Semiconductor Corporation FCP4N60 Rev. C1

www.fairchildsemi.com



 V_{GS} Same Type as DUT 50KQ Q_g 12\ 300nF F V_{DS} \mathbf{Q}_{gd} Q_{gs} DUT I_G = const. Charge Figure 12. Gate Charge Test Circuit & Waveform R VDS VDS 90% V_{DD} R_{G} 10% V_{GS} DUT V_{GS} ∏ 0 Figure 13. Resistive Switching Test Circuit & Waveforms BV_{DSS} BV_{DSS} - V_{DD} L $E_{AS} = \frac{1}{2} L I_{AS}^2$ V_{DS} $\mathsf{BV}_{\mathsf{DSS}}$ I_D 0 I_{AS} R_{G} VDD I_D (t) V_{GS} $V_{DS}(t)$ DUT V_{DD} Time t_n Figure 14. Unclamped Inductive Switching Test Circuit & Waveforms





ON Semiconductor and are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of ON Semiconductor's product/patent coverage may be accessed at <u>www.onsemi.com/site/pdf/Patent-Marking.pdf</u>. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using ON Semiconductor products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by ON Semiconductor. "Typical" parameters which may be provided in ON Semiconductor data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. ON Semiconductor does not convey any license under its patent rights of others. ON Semiconductor products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use ON Semiconductor has against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death ass

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT:

Literature Distribution Center for ON Semiconductor 19521 E. 32nd Pkwy, Aurora, Colorado 80011 USA Phone: 303-675-2175 or 800-344-3860 Toll Free USA/Canada Fax: 303-675-2176 or 800-344-3867 Toll Free USA/Canada Email: orderlit@onsemi.com N. American Technical Support: 800–282–9855 Toll Free USA/Canada Europe, Middle East and Africa Technical Support: Phone: 421 33 790 2910

Japan Customer Focus Center Phone: 81-3-5817-1050 ON Semiconductor Website: www.onsemi.com

Order Literature: http://www.onsemi.com/orderlit

For additional information, please contact your local Sales Representative

© Semiconductor Components Industries, LLC

X-ON Electronics

Largest Supplier of Electrical and Electronic Components

Click to view similar products for MOSFET category:

Click to view products by ON Semiconductor manufacturer:

Other Similar products are found below :

614233C 648584F IRFD120 JANTX2N5237 FCA20N60_F109 FDZ595PZ 2SK2545(Q,T) 405094E 423220D TPCC8103,L1Q(CM MIC4420CM-TR VN1206L SBVS138LT1G 614234A 715780A NTNS3166NZT5G SSM6J414TU,LF(T 751625C BUK954R8-60E NTE6400 SQJ402EP-T1-GE3 2SK2614(TE16L1,Q) 2N7002KW-FAI DMN1017UCP3-7 EFC2J004NUZTDG ECH8691-TL-W FCAB21350L1 P85W28HP2F-7071 DMN1053UCP4-7 NTE221 NTE222 NTE2384 NTE2903 NTE2941 NTE2945 NTE2946 NTE2960 NTE2967 NTE2969 NTE2976 NTE455 NTE6400A NTE2910 NTE2916 NTE2956 NTE2911 DMN2080UCB4-7 TK10A80W,S4X(S SSM6P69NU,LF DMP22D4UF0-7B